

Direct Attach DA1000™ LEDs

CxxxDA1000-Sxx000

Data Sheet

Cree's Direct Attach DA1000 LEDs are the next generation of solid-state LED emitters that combine highly efficient InGaN materials with Cree's proprietary device technology and silicon-carbide substrates to deliver superior value for the general-illumination market. The DA1000 LEDs are among the brightest in the lighting market while delivering a low forward voltage, resulting in a very bright and highly efficient solution. The bondpad-down design allows for a eutectic direct die-attach process, eliminating the need for wire bonds, and enables superior performance from improved thermal management.

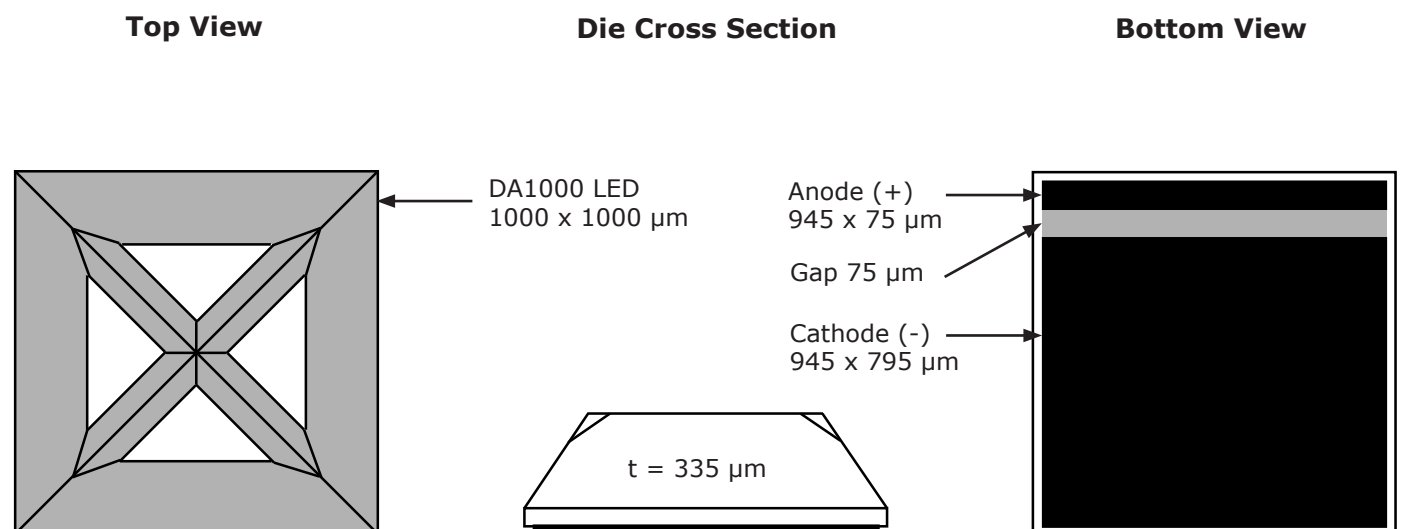
FEATURES

- Direct Attach LED Technology
- Rectangular LED RF Performance
 - 450 & 460 nm – 485 mW min
- High Reliability - Eutectic Attach
- Low Forward Voltage (Vf) – 3.15 V Typical at 350 mA
- Maximum DC Forward Current – 1000 mA
- InGaN Junction-Down Design for Improved Thermal Management
- No Wire Bonds Required

APPLICATIONS

- General Illumination
 - Aircraft
 - Decorative Lighting
 - Task Lighting
 - Outdoor Illumination
- White LEDs
- Camera Flash
- Projection Displays
- Automotive

CxxxDA1000-Sxx000 Chip Diagram





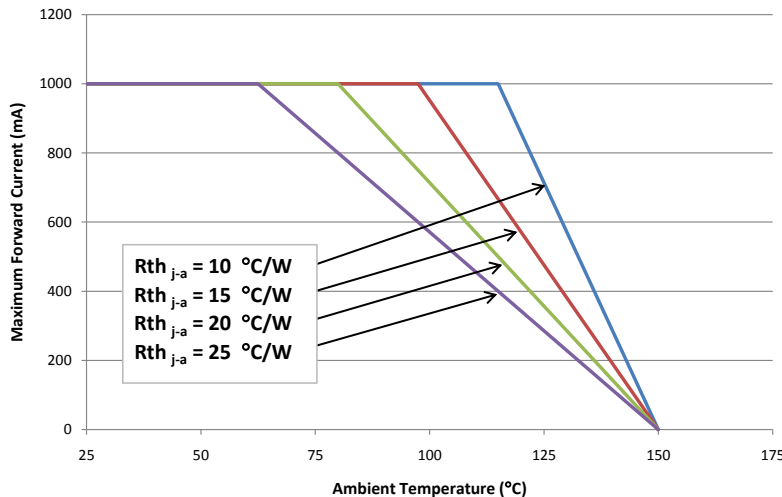
Maximum Ratings at $T_A = 25^\circ\text{C}$ <small>Notes 1,2 & 3</small>		CxxxDA1000-Sxx000
DC Forward Current		1000 mA
Peak Forward Current (1/10 duty cycle @ 1 kHz)		1250 mA
LED Junction Temperature		150°C
Reverse Voltage		5 V
Operating Temperature Range		-40°C to +100°C
Storage Temperature Range		-40°C to +100°C

Typical Electrical/Optical Characteristics at $T_A = 25^\circ\text{C}$, $I_f = 350\text{ mA}$ <small>Note 2</small>					
Part Number	Forward Voltage (V_f , V)			Reverse Current [$I(V_r=5V)$, μA]	Full Width Half Max (λ_D , nm)
	Min.	Typ.	Max.	Max.	Typ.
C450DA1000-Sxx000	2.7	3.15	3.5	2	20
C460DA1000-Sxx000	2.7	3.15	3.5	2	21

Mechanical Specifications			CxxxDA1000-Sxx000
Description	Dimension	Tolerance	
P-N Junction Area (μm)	960 x 960	± 35	
Chip Bottom Area (μm)	1000 x 1000	± 35	
Chip Top Area (μm)	630 x 630	± 45	
Chip Thickness (μm)	335	± 25	
AuSn Bond Pad Width – Anode (μm)	75	± 15	
AuSn Bond Pad Length – Anode (μm)	945	± 35	
AuSn Bond Pad Width – Cathode (μm)	795	± 35	
AuSn Bond Pad Length – Cathode (μm)	945	± 35	
Bond Pad Gap (μm)	75	± 15	
AuSn Bond Pad Thickness (μm)	3	± 0.5	

Notes:

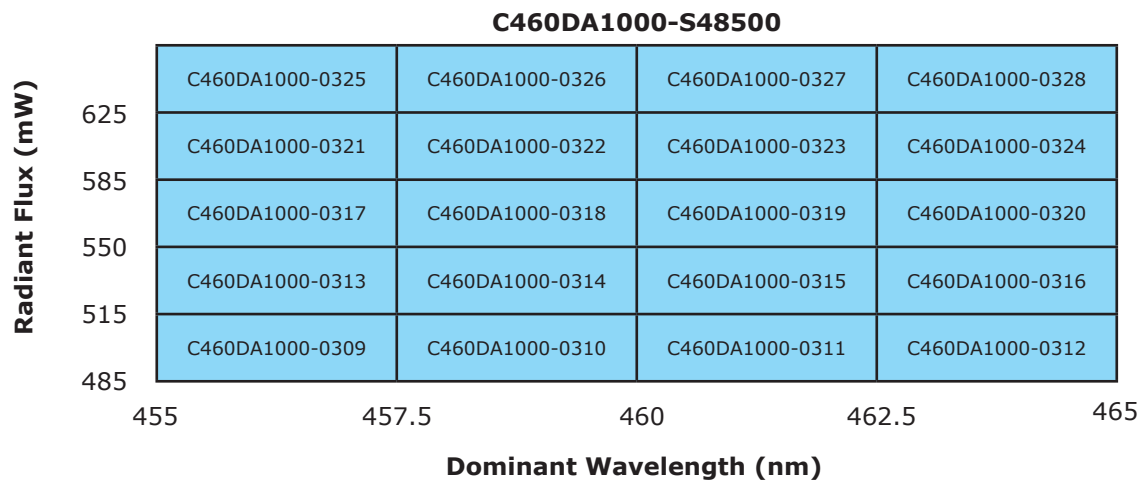
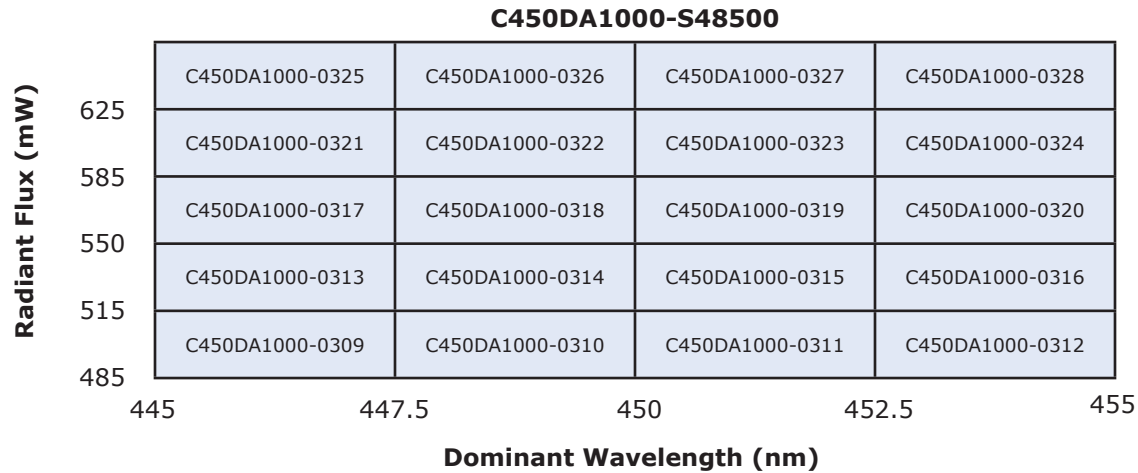
- Maximum ratings are package-dependent. The above ratings were determined using a Cree 3.45-mm x 3.45-mm SMT package (with silicone encapsulation and intrinsic AuSn metal die attach) for characterization. Ratings for other packages may differ. Junction temperature should be characterized in a specific package to determine limitations. Assembly processing temperature must not exceed 325°C (< 5 seconds).
- All products conform to the listed minimum and maximum specifications for electrical and optical characteristics when assembled and operated at 350 mA within the maximum ratings shown above. Efficiency decreases at higher currents. Typical values given are within the range of average values expected by manufacturer in large quantities and are provided for information only. All measurements were made using lamps in T-1¾ packages (with Hysol OS4000 epoxy encapsulant and intrinsic AuSn metal die attach). Optical characteristics measured in an integrating sphere using Illuminance E.
- The maximum forward current is determined by the thermal resistance between the LED junction and ambient. It is crucial for the end-product to be designed in a manner that minimizes the thermal resistance from the LED junction to ambient in order to optimize product performance.





Standard Bins for CxxxDA1000-Sxx000

LED chips are sorted to the **radiant flux** and **dominant wavelength** bins shown. A sorted die sheet contains die from only one bin. Sorted die kit (CxxxDA1000-Sxxxxx) orders may be filled with any or all bins (CxxxDA1000-xxxxx) contained in the kit. All radiant flux and dominant wavelength values shown and specified are at $I_f = 350$ mA.



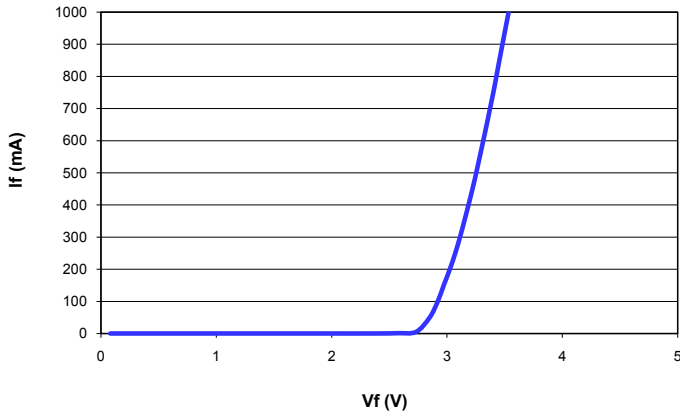
Note: The radiant-flux values above are representative of the die in a T-1¾ encapsulated 5-mm lamp.



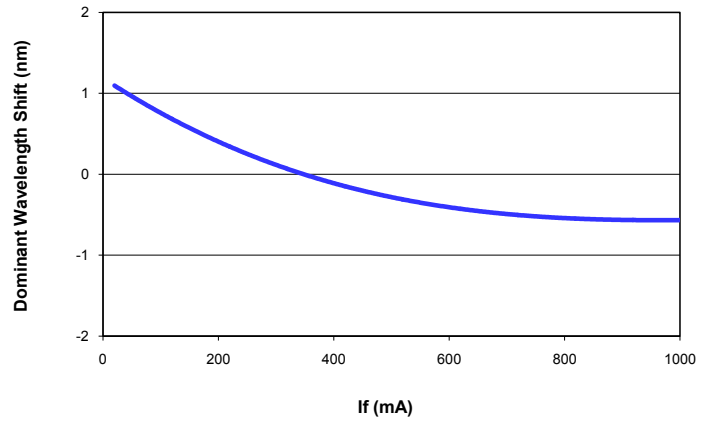
Characteristic Curves

These are representative measurements for the DA LED product. Actual curves will vary slightly for the various radiant flux and dominant wavelength bins.

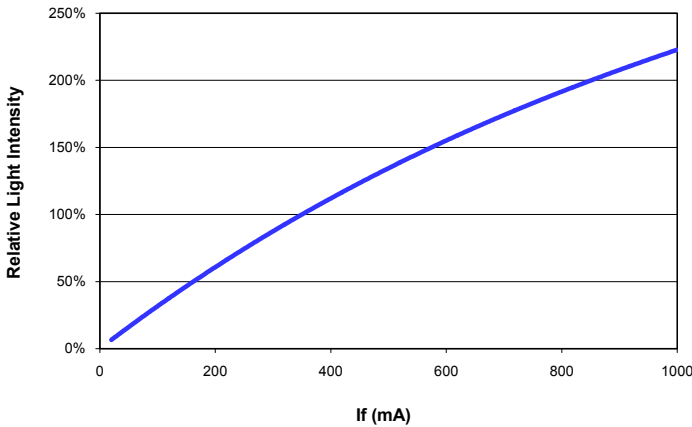
Forward Current vs. Forward Voltage



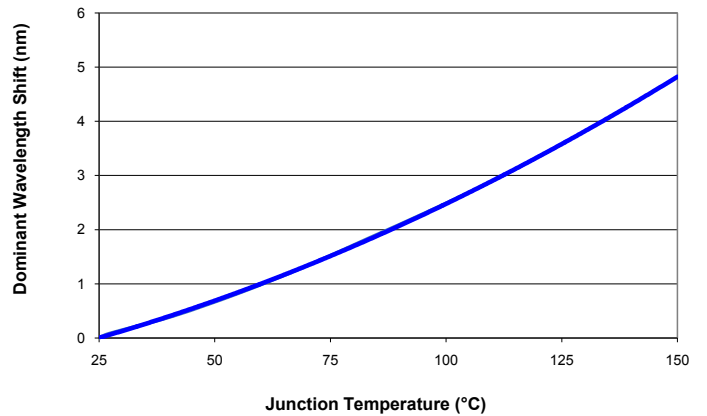
Wavelength Shift vs. Forward Current



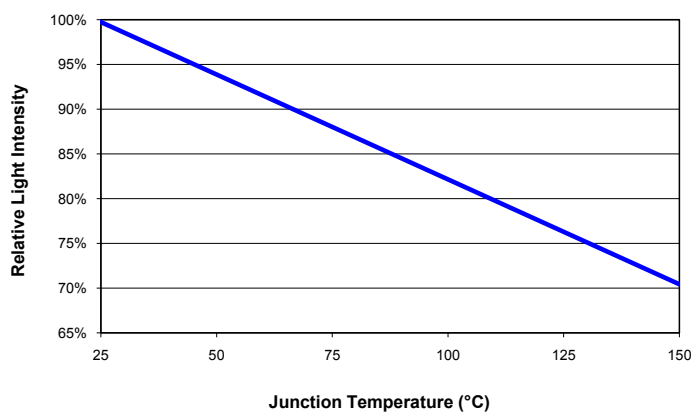
Relative Intensity vs. Forward Current



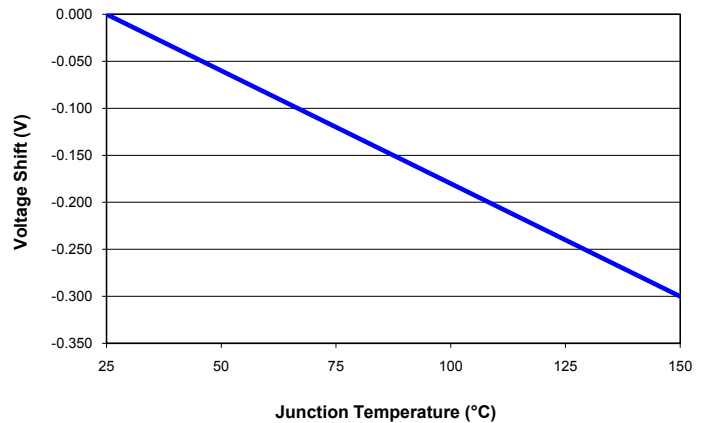
Dominant Wavelength Shift Vs Junction Temperature



Relative Light Intensity Vs Junction Temperature



Voltage Shift Vs Junction Temperature



Radiation Pattern

This is a representative radiation pattern for the DA LED product. Actual patterns will vary slightly for each chip.

